



RADIO TEST REPORT

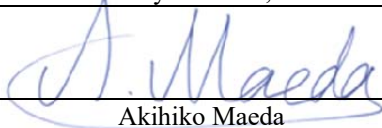
Test Report No. : 12717479H-A

Applicant : Mitsubishi Electric Corporation Himeji works
Type of Equipment : Smart Keyless System Smart Unit
Model No. : SKESAD-01
FCC ID : WAZSKESAD01
Test regulation : FCC Part 15 Subpart C: 2018
Test Result : Complied (Refer to SECTION 3.2)


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2. The results in this report apply only to the sample tested.
3. This sample tested is in compliance with above regulation.
4. The test results in this report are traceable to the national or international standards.
5. This test report covers Radio technical requirements. It does not cover administrative issues such as Manual or non-Radio test related Requirements. (if applicable)
6. The all test items in this test report are conducted by UL Japan, Inc. Ise EMC Lab.
7. This test report must not be used by the customer to claim product certification, approval, or endorsement by NVLAP, NIST, or any agency of the Federal Government.
8. The information provided from the customer for this report is identified in SECTION 1.

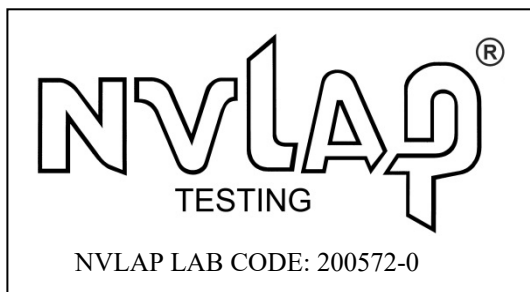
Date of test: February 6 and 17, 2019

Representative test engineer:


Akihiko Maeda
Engineer
Consumer Technology Division

Approved by:


Motoya Imura
Leader
Consumer Technology Division



This laboratory is accredited by the NVLAP LAB CODE 200572-0, U.S.A. The tests reported herein have been performed in accordance with its terms of accreditation.
*As for the range of Accreditation in NVLAP, you may refer to the WEB address,
http://japan.ul.com/resources/emc_accredited/

- ☐ The testing in which "Non-accreditation" is displayed is outside the accreditation scopes in UL Japan.
☒ There is no testing item of "Non-accreditation".

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Ise EMC Lab.

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REVISION HISTORY

Original Test Report No.: 12717479H-A

[illegible]

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SECTION 1: Customer information

Company Name	:	Mitsubishi Electric Corporation Himeji works
Address	:	840 Chiyoda-machi, Himeji, Hyogo 670-8677, Japan
Telephone Number	:	+81-79-298-9580
Facsimile Number	:	+81-79-298-9929
Contact Person	:	Shinichi Furuta

The information provided from the customer is as follows;

- Applicant, Type of Equipment, Model No. on the cover and other relevant pages
- SECTION 1: Customer information
- SECTION 2: Equipment under test (E.U.T.)
- SECTION 4: Operation of E.U.T. during testing

* The laboratory is exempted from liability of any test results affected from the above information in SECTION 2 and 4.

SECTION 2: Equipment under test (E.U.T.)

2.1 Identification of E.U.T.

Type of Equipment	:	Smart Keyless System Smart Unit
Model No.	:	SKESAD-01
Serial No.	:	Refer to Section 4, Clause 4.2
Rating	:	DC 12.0 V
Receipt Date of Sample (Information from test lab.)	:	February 4, 2019
Country of Mass-production	:	Japan
Condition of EUT	:	Engineering prototype (Not for Sale: This sample is equivalent to mass-produced items.)
Modification of EUT	:	No Modification by the test lab

2.2 Product Description

Model No: SKESAD-01, (referred to as the EUT in this report), is the Smart Keyless System Smart Unit.

Radio Specification

LF Part

Equipment Type	:	Transmitter
Type of modulation	:	ASK
Frequency of operation	:	125 kHz
Other clock frequency	:	-
Antenna Type	:	Inductive
Clock frequency	:	8 MHz

RF Part *

Type of Receiver	:	Receiver
Frequency of operation	:	315 MHz
Other clock frequency	:	30.32 MHz
Intermediate frequency	:	280 kHz
Antenna Type	:	Bar Antenna

* The test of receiver part was performed separately from this test report, and the conformability is confirmed.
RF Part test report No. 12717479H-B (FCC15B).

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SECTION 3: Test specification, procedures & results

3.1 Test Specification

Test Specification : FCC Part 15 Subpart C
FCC Part 15 final revised on March 12, 2018 and effective April 11, 2018

Title : FCC 47CFR Part15 Radio Frequency Device Subpart C Intentional Radiators
Section 15.207 Conducted limits
Section 15.209 Radiated emission limits; general requirements.

* Also the EUT complies with FCC Part 15 Subpart B.

3.2 Procedures and results

Item	Test Procedure	Specification	Remarks	Deviation	Worst margin	Results
Conducted Emission	<FCC> ANSI C63.10:2013 6 Standard test methods <IC> RSS-Gen 8.8	<FCC> Section 15.207 <IC> RSS-Gen 8.8	-	N/A	N/A *1)	N/A
Electric Field Strength of Fundamental Emission	<FCC> ANSI C63.10:2013 6 Standard test methods <IC> RSS-Gen 6.5, 6.12	<FCC> Section 15.209 <IC> RSS-210 4.4 RSS-Gen 8.9	Radiated	N/A	6.3 dB 125 kHz 0 deg. PK with Duty Factor	Complied a)
Electric Field Strength of Spurious Emission	<FCC> ANSI C63.10:2013 6 Standard test methods <IC> RSS-Gen 6.5, 6.6, 6.13	<FCC> Section 15.209 <IC> RSS-210 4.4 RSS-Gen 8.9	Radiated	N/A	22.5 dB 625 kHz, 0 deg. QP	Complied a)
-26dB Bandwidth	<FCC> ANSI C63.10:2013 6 Standard test methods <IC> -	<FCC> Reference data <IC> -	Radiated	N/A	N/A	Complied b)

Note: UL Japan, Inc.'s EMI Work Procedures No. 13-EM-W0420 and 13-EM-W0422.

*1) The test is not applicable since the EUT is not the device that is designed to be connected to the public utility (AC) power line.

a) Refer to APPENDIX 1 (data of Radiated emission)

b) Refer to APPENDIX 1 (data of -26 dB Bandwidth and 99 % Occupied Bandwidth)

Symbols:

Complied The data of this test item has enough margin, more than the measurement uncertainty.

Complied# The data of this test item meets the limits unless the measurement uncertainty is taken into consideration.

FCC 15.31 (e)

The EUT provides stable voltage constantly to the wireless transmitter regardless of input voltage.

Instead of a new battery, DC power supply was used for the test.

That does not affect the test result, therefore the EUT complies with the requirement.

FCC Part 15.203 Antenna requirement

It is impossible for end users to replace the antenna, because the antenna is mounted inside of the EUT. Therefore, the equipment complies with the antenna requirement of Section 15.203.

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3.3 Addition to standard

Item	Test Procedure	Specification	Remarks	Deviation	Worst margin	Results
99 % Occupied Band Width	RSS-Gen 6.7	-	Radiated	N/A	N/A	-

Note: UL Japan, Inc.'s EMI Work Procedures No. 13-EM-W0420 and 13-EM-W0422.

Other than above, no addition, exclusion nor deviation has been made from the standard.

3.4 Uncertainty

There is no applicable rule of uncertainty in this applied standard. Therefore, the following results are derived depending on whether or not laboratory uncertainty is applied.

The following uncertainties have been calculated to provide a confidence level of 95% using a coverage factor k=2.

Test distance	Radiated emission (+/-)
	9 kHz to 30 MHz
3 m	3.3 dB
10 m	3.2 dB

*Measurement distance

Polarity	Radiated emission (Below 1 GHz)			
	(3 m*)(+/-)		(10 m*)(+/-)	
	30 MHz to 200 MHz	200 MHz to 1000 MHz	30 MHz to 200 MHz	200 MHz to 1000 MHz
Horizontal	4.8 dB	5.2 dB	4.8 dB	5.0 dB
Vertical	5.0 dB	6.3 dB	4.9 dB	5.0 dB

* Measurement distance

Bandwidth
0.96 %

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3.5 Test Location

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NVLAP Lab. code: 200572-0 / FCC Test Firm Registration Number: 199967

Test site	IC Registration Number	Width x Depth x Height (m)	Size of reference ground plane (m) / horizontal conducting plane	Other rooms	Maximum measurement distance
No.1 semi-anechoic chamber	2973C-1	19.2 x 11.2 x 7.7	7.0 x 6.0	No.1 Power source room	10 m
No.2 semi-anechoic chamber	2973C-2	7.5 x 5.8 x 5.2	4.0 x 4.0	-	3 m
No.3 semi-anechoic chamber	2973C-3	12.0 x 8.5 x 5.9	6.8 x 5.75	No.3 Preparation room	3 m
No.3 shielded room	-	4.0 x 6.0 x 2.7	N/A	-	-
No.4 semi-anechoic chamber	2973C-4	12.0 x 8.5 x 5.9	6.8 x 5.75	No.4 Preparation room	3 m
No.4 shielded room	-	4.0 x 6.0 x 2.7	N/A	-	-
No.5 semi-anechoic chamber	-	6.0 x 6.0 x 3.9	6.0 x 6.0	-	-
No.6 shielded room	-	4.0 x 4.5 x 2.7	4.0 x 4.5	-	-
No.6 measurement room	-	4.75 x 5.4 x 3.0	4.75 x 4.15	-	-
No.7 shielded room	-	4.7 x 7.5 x 2.7	4.7 x 7.5	-	-
No.8 measurement room	-	3.1 x 5.0 x 2.7	3.1 x 5.0	-	-
No.9 measurement room	-	8.8 x 4.6 x 2.8	2.4 x 2.4	-	-
No.11 measurement room	-	6.2 x 4.7 x 3.0	4.8 x 4.6	-	-

* Size of vertical conducting plane (for Conducted Emission test) : 2.0 m x 2.0m for No.1, No.2, No.3, and No.4 semi-anechoic chambers and No.3 and No.4 shielded rooms.

3.6 Test data, Test instruments, and Test set up

Refer to APPENDIX.

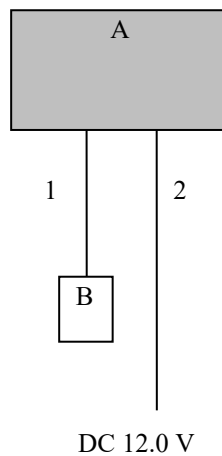
SECTION 4: Operation of E.U.T. during testing

4.1 Operating Modes

Test mode	Remarks
1) Tx 125 kHz Mod on	-

Justification : The system was configured in typical fashion (as a user would normally use it) for testing.

4.2 Configuration and peripherals



* Cabling and setup(s) were taken into consideration and test data was taken under worse case conditions.

Description of EUT and Support equipment

No.	Item	Model number	Serial number	Manufacturer	Remarks
A	Smart Keyless System Smart Unit	SKESAD-01	20190131-E1 (No.1)	Mitsubishi Electric Corporation Himeji works	EUT
B	SW BOX	SW BOX2	No.16	Mitsubishi Electric Corporation Himeji works	-

List of cables used

No.	Name	Length (m)	Shield		Remarks
			Cable	Connector	
1	DC and Signal Cable	1.0	Unshielded	Unshielded	-
2	DC Cable	1.5	Unshielded	Unshielded	(No.1)

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SECTION 5: Radiated emission (Fundamental and Spurious Emission)

Test Procedure

EUT was placed on a urethane platform of nominal size, 0.5 m by 1.0 m, raised 0.8 m above the conducting ground plane.

The Radiated Electric Field Strength has been measured in a Semi Anechoic Chamber with a ground plane.

Frequency : From 9 kHz to 30 MHz

The EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity.

The measurements were performed for vertical polarization (antenna angle: 0 deg., 45 deg., 90 deg., and 135 deg.) and horizontal polarization.

*Refer to Figure 1 about Direction of the Loop Antenna.

Frequency: From 30 MHz to 1 GHz

The measuring antenna height varied between 1 and 4 m and EUT was rotated a full revolution in order to obtain the maximum value of the electric field intensity.

The measurements were performed for both vertical and horizontal antenna polarization.

The test was made with the detector (RBW / VBW) in the following table.

When using Spectrum analyzer, the test was made with adjusting span to zero by using peak hold.

Test Antennas are used as below;

Frequency	Below 30 MHz	30 MHz to 200 MHz	200 MHz to 1 GHz
Antenna Type	Loop	Biconical	Logperiodic

Frequency	From 9 kHz to 90 kHz and From 110 kHz to 150 kHz	From 90 kHz to 110 kHz	From 150 kHz to 490 kHz	From 490 kHz to 30 MHz	From 30 MHz to 1 GHz
Instrument used	Test Receiver				
Detector	PK / AV	QP	PK / AV	QP	QP
IF Bandwidth	200 Hz	200 Hz	9 kHz	9 kHz	120 kHz
Test Distance	3 m *1)	3 m *1)	3 m *1)	3 m *2)	3 m

*1) Distance Factor: $40 \times \log(3 \text{ m} / 300 \text{ m}) = -80 \text{ dB}$

*2) Distance Factor: $40 \times \log(3 \text{ m} / 30 \text{ m}) = -40 \text{ dB}$

Although these tests were performed other than open field test site, adequate comparison measurements were confirmed against 30 m open field test site. Therefore sufficient tests were made to demonstrate that the alternative site produces results that correlate with the ones of tests made in an open field based on KDB 414788.

These tests were performed in semi anechoic chamber. Therefore the measured level of emissions may be higher than if measurements were made without a ground plane.

However test results were confirmed to pass against standard limit.

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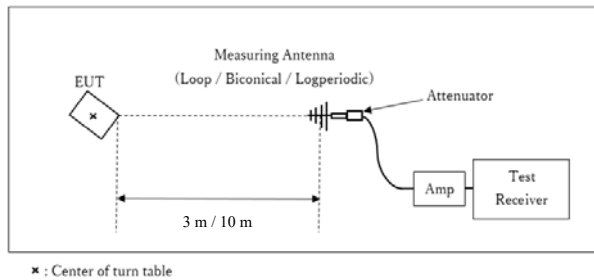
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[Test Setup]
Below 1 GHz



Test Distance: 3 m / 10 m

- The carrier level and noise levels were confirmed at each position of X, Y and Z axes of EUT to see the position of maximum noise, and the test was made at the position that has the maximum noise.

The test results and limit are rounded off to one decimal place, so some differences might be observed.

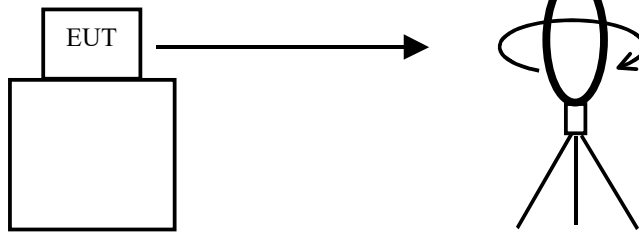
Measurement range : 9 kHz - 1 GHz
Test data : APPENDIX 1
Test result : Pass

Date: February 6, 2019
February 17, 2019

Test engineer: Yuta Moriya
Akihiko Maeda

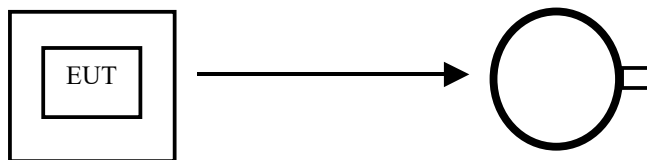
Figure 1: Direction of the Loop Antenna

Side View (Vertical)



.....

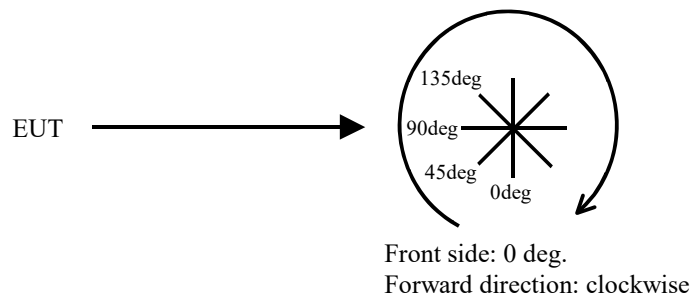
Top View (Horizontal)



Antenna was not rotated.

.....

Top View (Vertical)



SECTION 6: -26dB Bandwidth

Test Procedure

The test was measured with a spectrum analyzer using a test fixture.

Test	Span	RBW	VBW	Sweep	Detector	Trace	Instrument used
-26 dB Bandwidth	50 kHz	510 Hz	1.6 kHz	Auto	Peak	Max Hold	Spectrum Analyzer

Test data : APPENDIX 1

Test result : Pass

SECTION 7: 99% Occupied Bandwidth

Test Procedure

The test was measured with a spectrum analyzer using a test fixture.

Test	Span	RBW	VBW	Sweep	Detector	Trace	Instrument used
99 % Occupied Bandwidth	Enough width to display emission skirts	1 to 5 % of OBW	Three times of RBW	Auto	Peak *1)	Max Hold *1)	Spectrum Analyzer

*1) The measurement was performed with Peak detector, Max Hold since the duty cycle was not 100 %.
Peak hold was applied as Worst-case measurement.

Test data : APPENDIX 1

Test result : Pass

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APPENDIX 1: Test data

Radiated Emission below 30 MHz (Fundamental and Spurious Emission)

Report No. 12717479H
Test place Ise EMC Lab.
Semi Anechoic Chamber No.1
Date February 6, 2019
Temperature / Humidity 22 deg. C / 42% RH
Engineer Yuta Moriya
Mode Tx 125kHz Mod on

PK or QP

Ant Deg [deg] or Polarity [Hori/Vert]	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit dBuV/m	Margin [dB]	Remark
0	0.12500	PK	105.9	19.7	-74.0	32.3	-	19.3	45.6	26.3	Fundamental
0	0.25000	PK	68.0	19.7	-74.0	32.3	-	-18.6	39.6	58.2	
0	0.37500	PK	65.5	19.6	-73.9	32.3	-	-21.1	36.1	57.2	
0	0.50000	QP	36.1	19.6	-33.9	32.2	-	-10.4	33.6	44.0	
0	0.62500	QP	55.7	19.6	-33.9	32.2	-	9.2	31.7	22.5	
0	0.75000	QP	32.6	19.6	-33.9	32.2	-	-13.9	30.1	44.0	
0	0.87500	QP	49.4	19.6	-33.8	32.2	-	3.0	28.7	25.7	
0	1.00000	QP	31.6	19.6	-33.8	32.2	-	-14.8	27.6	42.4	
0	1.12500	QP	45.2	19.6	-33.8	32.2	-	-1.2	26.5	27.7	
0	1.25000	QP	30.9	19.6	-33.8	32.2	-	-15.5	25.6	41.1	

Result = Reading + Ant Factor + Loss (Cable + Attenuator + Filter + D.Factor) - Gain(Amplifier)

PK with Duty factor

Ant Deg [deg]	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit dBuV/m	Margin [dB]	Remark
0	0.12500	PK	105.9	19.7	-74.0	32.3	0.0	19.3	25.6	6.3	
0	0.25000	PK	68.0	19.7	-74.0	32.3	0.0	-18.6	19.6	38.2	
0	0.37500	PK	65.5	19.6	-73.9	32.3	0.0	-21.1	16.1	37.2	

Result = Reading + Ant Factor + Loss (Cable + Attenuator + Filter + D.Factor) - Gain(Amplifier) + Duty factor *

* Since the peak emission result satisfied the average limit, duty factor was omitted.

Result of the fundamental emission at 3m without Distance factor

PK or QP

Ant Deg [deg]	Frequency [MHz]	Detector	Reading [dBuV]	Ant Factor [dB/m]	Loss [dB]	Gain [dB]	Duty Factor [dB]	Result [dBuV/m]	Limit dBuV/m	Margin [dB]	Remark
0	0.12500	PK	105.9	19.7	6.0	32.3	-	99.3	-	-	Fundamental

Result = Reading + Ant Factor + Loss (Cable+Attenuator+Filter) - Gain(Amplifier)

* All spurious emissions lower than this result.

*The test result is rounded off to one or two decimal places, so some differences might be observed.

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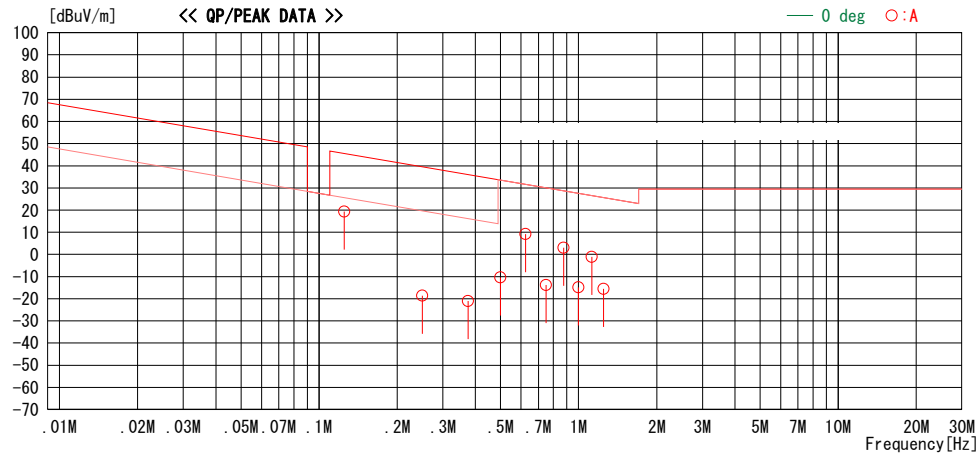
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Radiated Emission below 30 MHz (Fundamental and Spurious Emission)
(Plot data, Worst case)

Report No. 12717479H
Test place Ise EMC Lab.
Semi Anechoic Chamber No.1
Date February 6, 2019
Temperature / Humidity 22 deg. C / 42% RH
Engineer Yuta Moriya
Mode Tx 125kHz Mod on



*These plots data contains sufficient number to show the trend of characteristic features for EUT.

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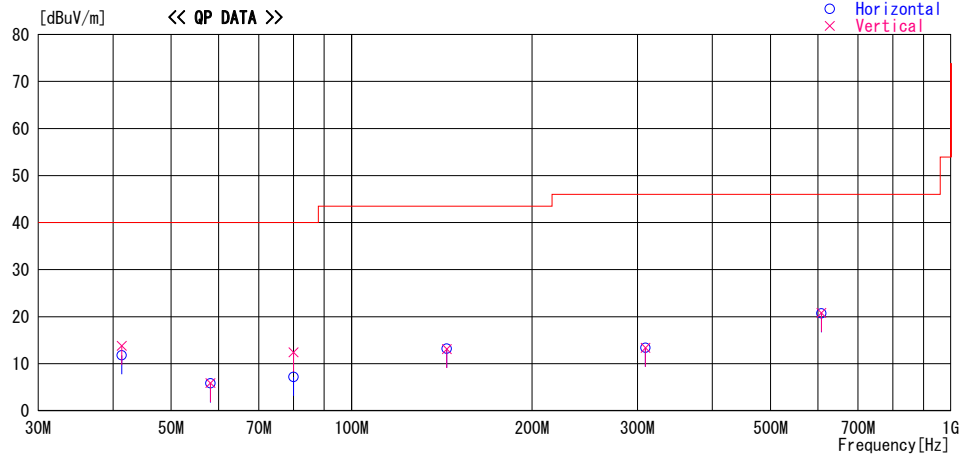
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Radiated Emission above 30 MHz (Spurious Emission)

Report No. 12717479H
Test place Ise EMC Lab.
Semi Anechoic Chamber No.1
Date February 17, 2019
Temperature / Humidity 20 deg. C / 51 % RH
Engineer Akihiko Maeda
(Below 1 GHz)
Mode Mode 1

LIMIT : FCC15.209 3m, below 1GHz:QP, above 1GHz:PK
All other spurious emissions were less than 20dB for the limit.



Frequency	Reading	DET	Antenna Factor	Loss& Gain	Level	Angle	Height	Polar.	Limit	Margin	Comment
[MHz]	[dBuV]		[dB/m]	[dB]	[dBuV/m]	[Deg]	[cm]		[dBuV/m]	[dB]	
41.333	22.4	QP	14.2	-24.8	11.8	334	150	Hori.	40.0	28.2	
41.333	24.4	QP	14.2	-24.8	13.8	234	232	Vert.	40.0	26.2	
58.160	22.0	QP	8.3	-24.5	5.8	148	179	Hori.	40.0	34.2	
58.160	22.1	QP	8.3	-24.5	5.9	1	118	Vert.	40.0	34.1	
80.000	24.4	QP	6.9	-24.1	7.2	287	233	Hori.	40.0	32.8	
80.000	29.6	QP	6.9	-24.1	12.4	0	205	Vert.	40.0	27.6	
144.184	21.8	QP	14.7	-23.3	13.2	359	150	Hori.	43.5	30.3	
144.184	21.7	QP	14.7	-23.3	13.1	226	150	Vert.	43.5	30.4	
309.334	21.4	QP	13.9	-21.9	13.4	305	150	Hori.	46.0	32.6	
309.334	21.4	QP	13.9	-21.9	13.4	215	100	Vert.	46.0	32.6	
608.124	21.5	QP	19.5	-20.3	20.7	359	123	Hori.	46.0	25.3	
608.124	21.6	QP	19.5	-20.3	20.8	0	100	Vert.	46.0	25.2	

CHART: WITH FACTOR

ANT TYPE: - 30 MHz: LOOP, 30 MHz - 200 MHz: BICONICAL, 200 MHz - 1000 MHz: LOGPERIODIC, 1000 MHz -: HORN
CALCULATION: RESULT = READING + ANT FACTOR + LOSS & GAIN (CABLE + ATT - GAIN(AMP))

*The test result is rounded off to one or two decimal places, so some differences might be observed.

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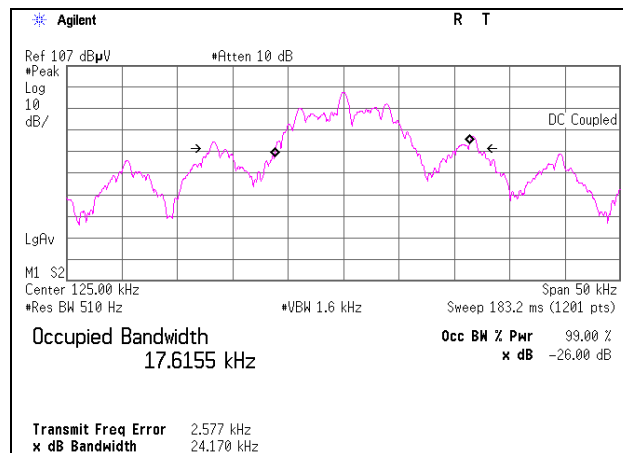
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-26 dB Bandwidth and 99 % Occupied Bandwidth

Report No. 12717479H
Test place Ise EMC Lab.
Semi Anechoic Chamber No.4
Date February 17, 2019
Temperature / Humidity 20 deg. C / 51 % RH
Engineer Akihiko Maeda
Mode Tx 125 kHz

-26 dB Bandwidth [kHz]	99 % Occupied Bandwidth [kHz]
24.170	17.6155



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APPENDIX 2: Test instruments

Test Instruments

Test item	LIMS ID	Description	Manufacturer	Model	Serial	Last Calibration Date	Calibration Due Date	Cal Int
RE	142226	Measure	KOMELON	KMC-36	-	-	-	-
RE	141998	AC1_Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 10m	DA-06881	06/18/2018	06/30/2020	24
RE	141566	Thermo-Hygrometer	CUSTOM	CTH-201	A08Q26	01/11/2019	01/31/2020	12
RE	141254	Loop Antenna	Rohde & Schwarz	HFH2-Z2	100017	10/11/2018	10/31/2019	12
RE	141215	Coaxial Cable	Fujikura/Suhner/TSJ	5D-2W/3D-2W/RG400u/RFM-E421(SW)	-/01068 (Switcher)	06/04/2018	06/30/2019	12
RE	141582	Pre Amplifier	SONOMA INSTRUMENT	310	260834	02/08/2019	02/29/2020	12
RE	141213	Attenuator(6dB)	Weinschel Corp	2	BK7971	11/05/2018	11/30/2019	12
RE	141413	Coaxial Cable	UL Japan	-	-	06/12/2018	06/30/2019	12
RE	141530	Digital Tester	Fluke Corporation	FLUKE 26-3	78030621	08/21/2018	08/31/2019	12
RE	142011	AC4_Semi Anechoic Chamber(NSA)	TDK	Semi Anechoic Chamber 3m	DA-10005	06/28/2018	06/30/2020	24
RE	141562	Thermo-Hygrometer	CUSTOM	CTH-201	0010	01/11/2019	01/31/2020	12
RE	141545	DIGITAL HiTESTER	HIOKI	3805	51201148	01/29/2019	01/31/2020	12
RE	142227	Measure	KOMELON	KMC-36	-	-	-	-
RE	141901	Spectrum Analyzer	AGILENT	E4440A	MY48250080	10/04/2018	10/31/2019	12
RE	141397	Coaxial Cable	UL Japan	-	-	06/13/2018	06/30/2019	12
RE	141425	Biconical Antenna	Schwarzbeck	BBA9106	1302	06/01/2018	06/30/2019	12
RE	141267	Logperiodic Antenna(200-1000MHz)	Schwarzbeck	VUSLP9111B	911B-192	06/01/2018	06/30/2019	12
RE	148898	Attenuator	KEYSIGHT	8491A	MY52462282	10/03/2018	10/31/2019	12
RE	141152	EMI measurement program	TSJ	TEPTO-DV	-	-	-	-
RE	141950	EMI Test Receiver	Rohde & Schwarz	ESU26	100412	06/15/2018	06/30/2019	12
RE	141949	Test Receiver	Rohde & Schwarz	ESCI	100767	08/06/2018	08/31/2019	12

*Hyphens for Last Calibration Date, Calibration Due Date and Cal Int (month) are instruments that Calibration is not required (e.g. software), or instruments checked in advance before use.

The expiration date of the calibration is the end of the expired month.

All equipment is calibrated with valid calibrations. Each measurement data is traceable to the national or international standards.

As for some calibrations performed after the tested dates, those test equipment have been controlled by means of an unbroken chains of calibrations.

Test item:

RE: Spurious emission

UL Japan, Inc.

Ise EMC Lab.

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